

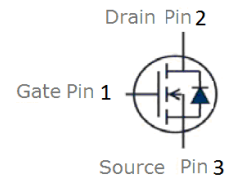
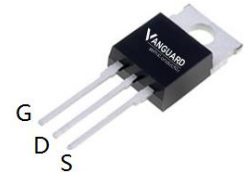
Features

- N-Channel, 5V Logic Level Control
- Enhancement mode
- Fast Switching
- Very low on-resistance $R_{DS(on)}$ @ $V_{GS}=4.5\text{ V}$
- 100% Avalanche test
- Pb-free lead plating; RoHS compliant



V_{DS}	120	V
$R_{DS(on),TYP} @ V_{GS}=10\text{ V}$	11.5	m Ω
$R_{DS(on),TYP} @ V_{GS}=4.5\text{ V}$	13	m Ω
I_D	63	A

TO-220AB



Part ID	Package Type	Marking	Tape and reel information
VST012N12MS	TO-220AB	012N12M	50pcs/Tube

Maximum ratings, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Unit	
Common Ratings ($T_c=25^\circ\text{C}$ Unless Otherwise Noted)				
V_{GS}	Gate-Source Voltage	± 20	V	
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	120	V	
T_j	Maximum Junction Temperature	175	$^\circ\text{C}$	
T_{STG}	Storage Temperature Range	-55 to 175	$^\circ\text{C}$	
I_S	Diode Continuous Forward Current	$T_c=25^\circ\text{C}$ 63	A	
Mounted on Large Heat Sink				
I_D	Continuous Drain current@ $V_{GS}=10\text{V}$	$T_c=25^\circ\text{C}$	63	A
		$T_c=100^\circ\text{C}$	40	A
I_{DM}	Pulse Drain Current Tested ①	$T_c=25^\circ\text{C}$	240	A
P_D	Maximum Power Dissipation	$T_c=25^\circ\text{C}$	100	W
$R_{\theta JC}$	Thermal Resistance-Junction to Case		1.5	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance Junction-Ambient		62	$^\circ\text{C/W}$
Drain-Source Avalanche Ratings				
EAS	Avalanche Energy, Single Pulsed ②		56	mJ

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ T_c = 25°C (unless otherwise stated)						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	120	--	--	V
I _{DSS}	Zero Gate Voltage Drain Current(T _c =25°C)	V _{DS} =100V, V _{GS} =0V	--	--	1	μA
	Zero Gate Voltage Drain Current(T _c =125°C)	V _{DS} =100V, V _{GS} =0V	--	--	100	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V	--	--	±100	nA
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.3	2.0	2.6	V
R _{DS(ON)}	Drain-Source On-State Resistance ^③	V _{GS} =10V, I _D =20A	--	11.5	14	mΩ
R _{DS(ON)}	Drain-Source On-State Resistance ^③	V _{GS} =4.5V, I _D =10A	--	13.0	16	mΩ
Dynamic Electrical Characteristics @ T_c = 25°C (unless otherwise stated)						
R _g	Gate Resistance	V _{DS} =30V, V _{GS} =0V, f=1MHz	--	1.8	--	Ω
C _{iss}	Input Capacitance		--	3910	--	pF
C _{oss}	Output Capacitance		--	305	--	pF
C _{rss}	Reverse Transfer Capacitance		--	230	--	pF
Q _g	Total Gate Charge	V _{DS} =60V, I _D =30A, V _{GS} =10V	--	54	--	nC
Q _{gs}	Gate-Source Charge		--	13	--	nC
Q _{gd}	Gate-Drain Charge		--	22	--	nC
Switching Characteristics						
t _{d(on)}	Turn-on Delay Time	V _{DD} =60V, I _D =20A, R _G =6.8Ω, V _{GS} =10V	--	24	--	nS
t _r	Turn-on Rise Time		--	85	--	nS
t _{d(off)}	Turn-Off Delay Time		--	55	--	nS
t _f	Turn-Off Fall Time		--	90	--	nS
Source- Drain Diode Characteristics @ T_c = 25°C (unless otherwise stated)						
V _{SD}	Forward on voltage	I _{SD} =20A, V _{GS} =0V	--	0.79	1.2	V
t _{rr}	Reverse Recovery Time	T _J =25°C, I _{sd} =10A, V _{GS} =0V	--	50	--	nS
Q _{rr}	Reverse Recovery Charge	di/dt=100A/μs		145		nC

NOTE:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by T_{Jmax}, starting T_J = 25°C, L = 0.5mH, R_G = 25Ω, I_{AS} = 15A, V_{GS} = 10V. Part not recommended for use above this value
- ③ Pulse width ≤ 300μs; duty cycle ≤ 2%.

Typical Characteristics

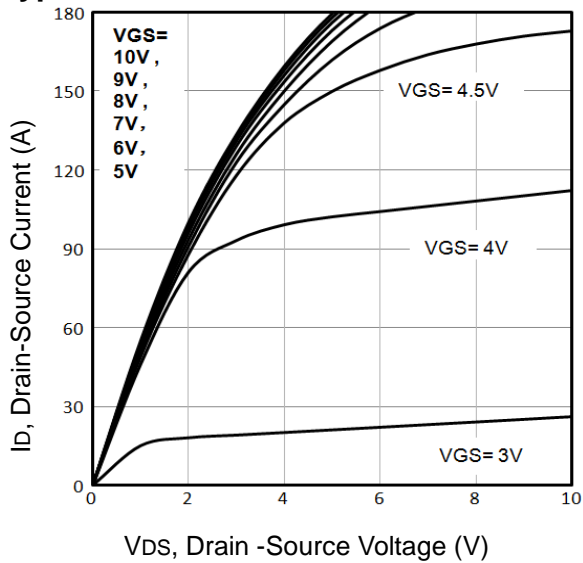


Fig1. Typical Output Characteristics

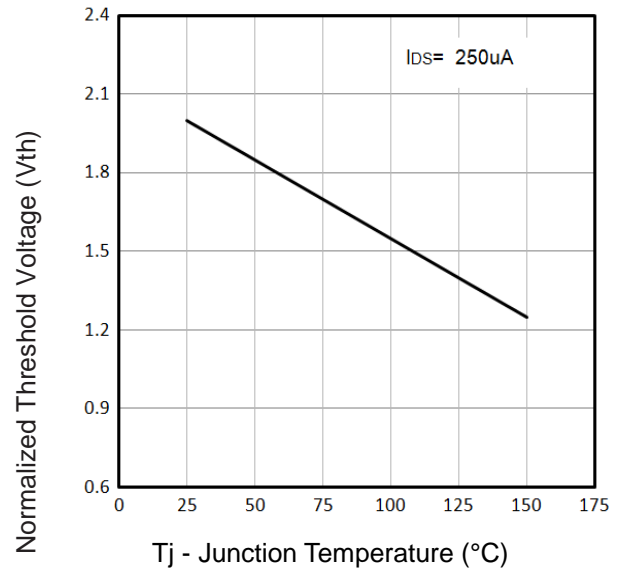


Fig2. Normalized Threshold Voltage Vs. Temperature

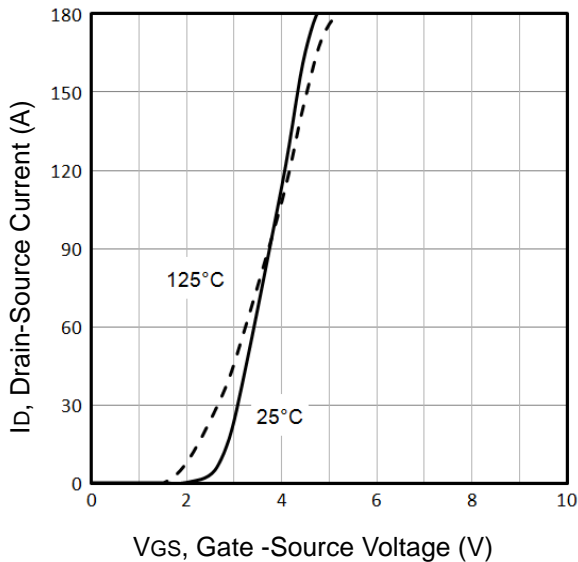


Fig3. Typical Transfer Characteristics

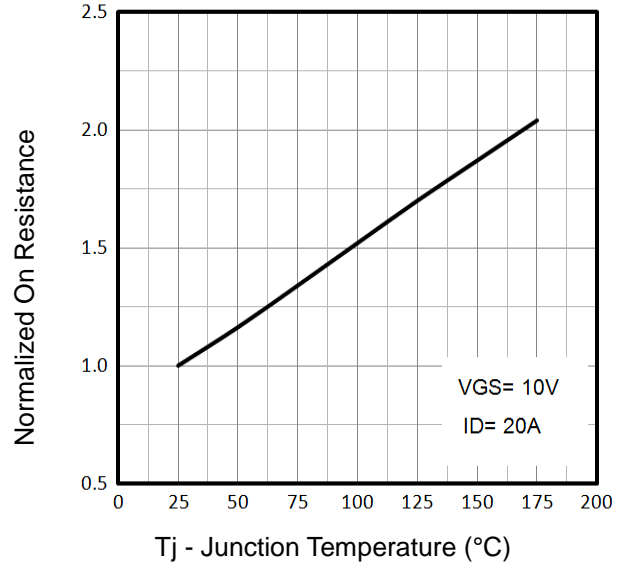


Fig4. Normalized On-Resistance Vs. Temperature

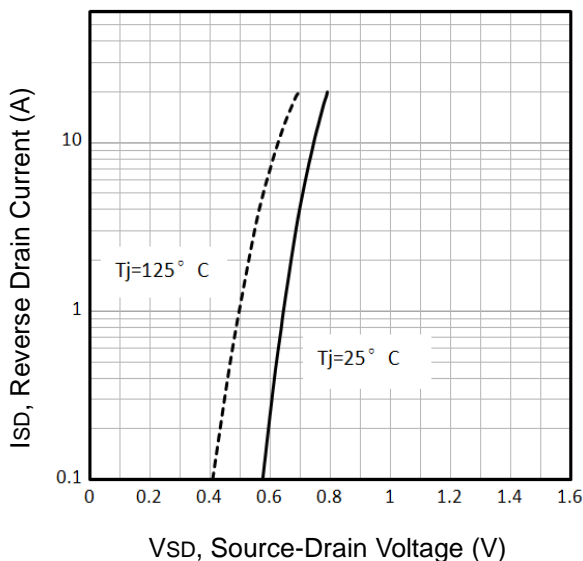


Fig5. Typical Source-Drain Diode Forward Voltage

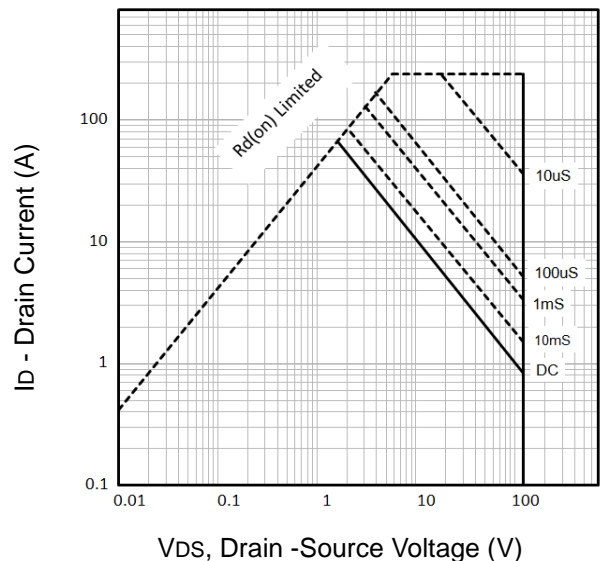


Fig6. Maximum Safe Operating Area

Typical Characteristics

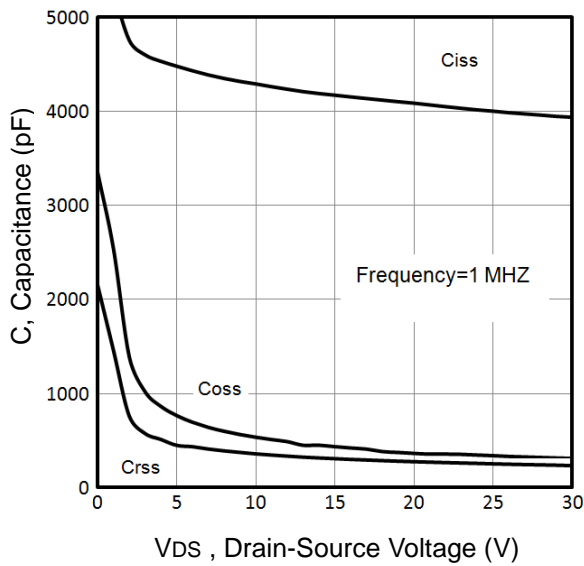


Fig7. Typical Capacitance Vs.Drain-Source

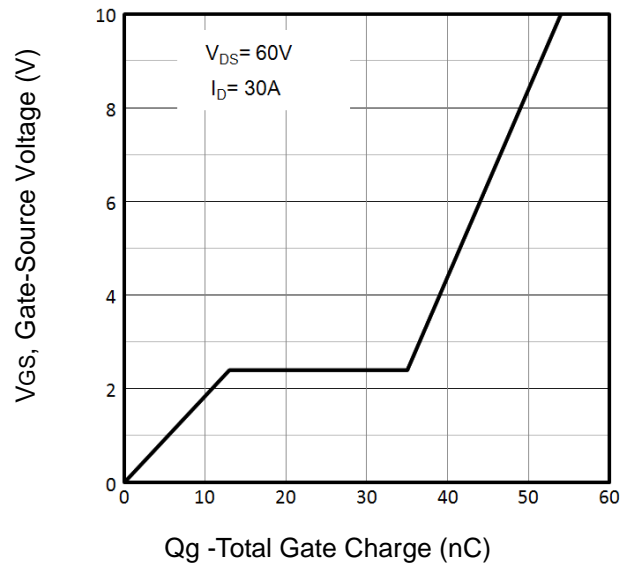


Fig8. Typical Gate Charge Vs.Gate-Source

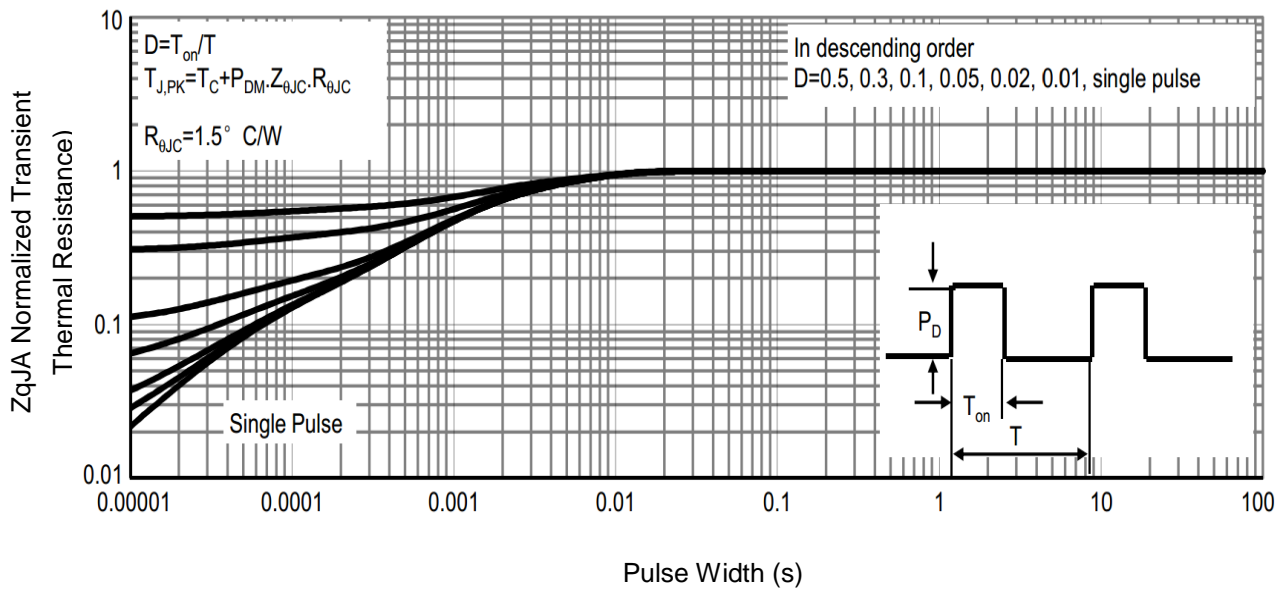


Fig9. Normalized Maximum Transient Thermal Impedance

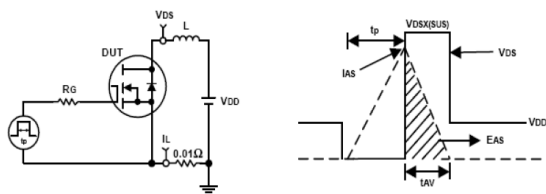


Fig10. Unclamped Inductive Test Circuit and waveforms

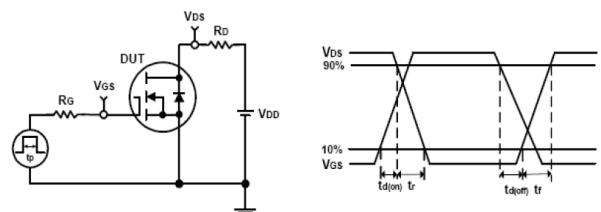
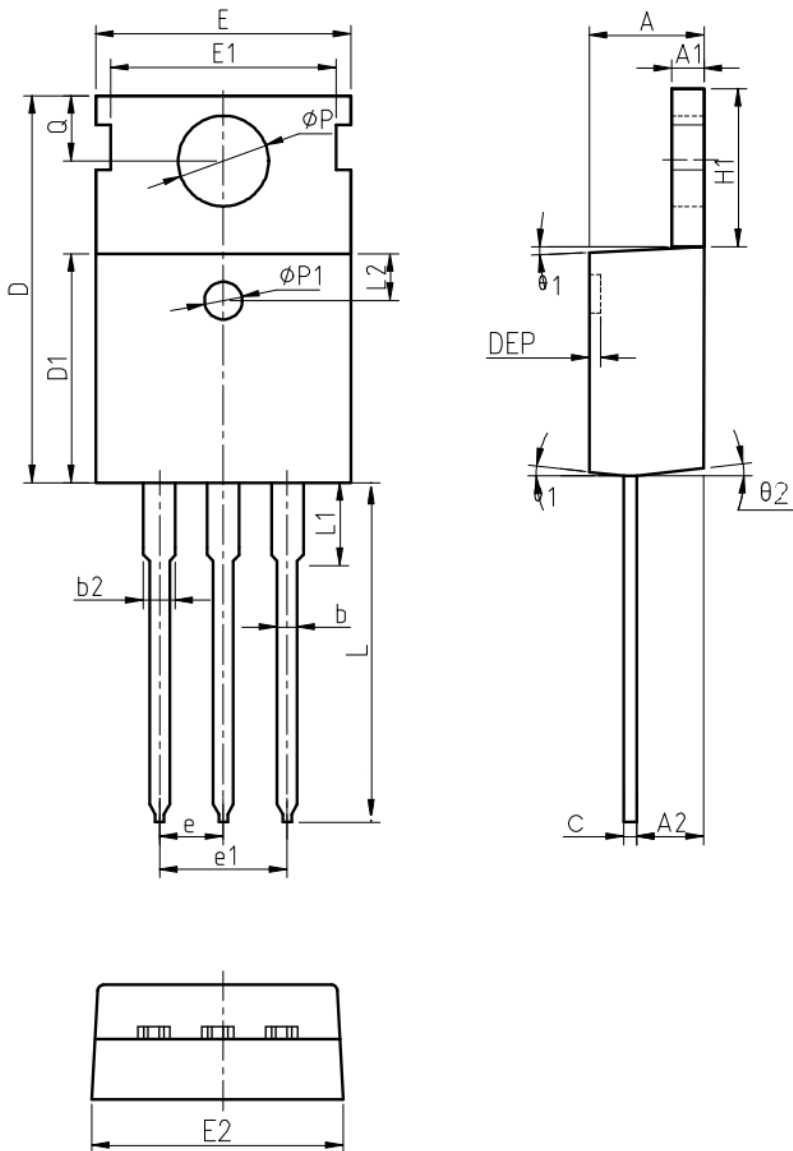


Fig11. Switching Time Test Circuit and waveforms

TO-220AB Package Outline



Symbol	Dimensions (unit: mm)		
	Min	Typ	Max
A	4.30	4.52	4.70
A1	1.15	1.30	1.40
A2	2.20	2.40	2.60
b	0.70	0.80	1.00
b2	1.17	1.32	1.50
c	0.45	0.50	0.61
D	15.30	15.65	15.90
D1	9.00	9.20	9.40
DEP	0.05	0.10	0.25
E	9.66	9.90	10.28
E1	-	8.70	-
E2	9.80	10.00	10.20
$\phi P1$	1.40	1.50	1.60
e	2.54 BSC		
e1	5.08 BSC		
H1	6.40	6.50	6.80
L	12.70		14.27
L1			3.95
L2	2.40	2.50	2.60
ϕP	3.53	3.60	3.70
Q	2.70	2.80	2.90
$\theta 1$	5 °	7 °	9 °
$\theta 2$	1 °	3 °	5 °

Notes:

1. Refer to JEDEC TO-220 variation AB
2. Dimension "D" and "E" do NOT include mold flash. Mold flash shall not exceed 0.127mm per side.

Customer Service

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